
**Automation systems and
integration — Quality information
framework (QIF) — An integrated
model for manufacturing quality
information**

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Foreword

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This document was prepared by the Digital Metrology Standards Consortium (DMSC) (as ANSI QIF 3.0 - 2018) and drafted in accordance with its editorial rules. It was assigned to Technical Committee ISO/TC 184, Automation systems and integration, Subcommittee SC 4, Industrial data, and adopted under the "fast-track procedure".

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

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